Panasonic

2SC5026

Silicon NPN epitaxial planar type

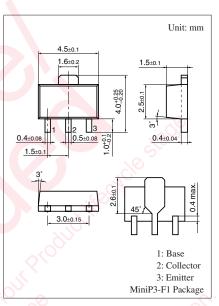
For low-frequency output amplification Complementary to 2SA1890

Features

- \bullet Low collector-emitter saturation voltage $V_{CE(sat)}$
- High collector-emitter voltage (Base open) V_{CEO}
- Mini Power type package, allowing downsizing of the equipment and automatic insertion through the tape packing and the magazine packing

Absolute Maximum Ratings $T_a = 23$ C					
Parameter	Symbol	Rating	Unit		
Collector-base voltage (Emitter open)	V _{CBO}	80	v		
Collector-emitter voltage (Base open)	V _{CEO}	80	V		
Emitter-base voltage (Collector open)	V _{EBO}	5	V		
Collector current	I _C	1	A		
Peak collector current	I _{CP}	1.5	А		
Collector power dissipation *	P _C	1	W		
Junction temperature	Tj	150	°C		
Storage temperature	T _{stg}	-55 to +150	⊳ °C ⊘		





Marking Symbol: 2A

Note) *: Copper plate at the collector is more than 1 cm² in area, 1.7 mm in thickness Absolute maximum rating without heat sink for P_C is 0.5 W

Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

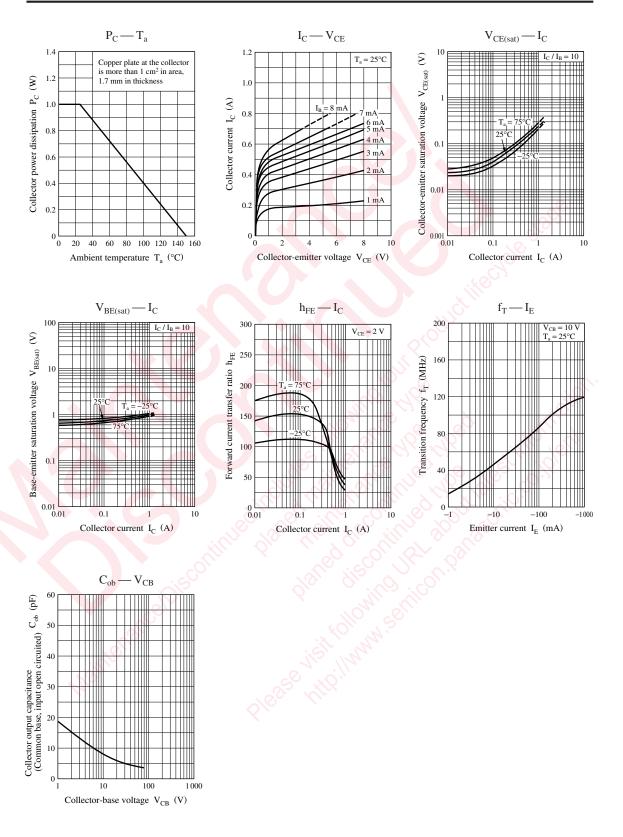
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V _{CBO}	$I_{\rm C} = 10 \ \mu A, I_{\rm E} = 0$	80			V
Collector-emitter voltage (Base open)	V _{CEO}	$I_{\rm C} = 1 \text{ mA}, I_{\rm B} = 0$	80			V
Emitter-base voltage (Collector open)	V _{EBO}	$I_{\rm E} = 10 \ \mu A, I_{\rm C} = 0$	5			V
Collector-base cutoff current (Emitter open)	I _{CBO}	$V_{CB} = 40 \text{ V}, I_E = 0$			0.1	μΑ
Forward current transfer ratio	h _{FE1} *2	$V_{CE} = 2 V, I_C = 100 mA$	120		340	_
	h _{FE2} *1	$V_{CE} = 2 V, I_C = 500 mA$	60			
Collector-emitter saturation voltage	V _{CE(sat)}	$I_{\rm C} = 500 \text{ mA}, I_{\rm B} = 50 \text{ mA}$		0.15	0.3	V
Base-emitter saturation voltage *1	V _{BE(sat)}	$I_{\rm C} = 500 \text{ mA}, I_{\rm B} = 50 \text{ mA}$		0.85	1.2	V
Transition frequency	f _T	$V_{CB} = 10 \text{ V}, \text{ I}_{\text{E}} = -50 \text{ mA}, \text{ f} = 200 \text{ MHz}$		120		MHz
Collector output capacitance	C _{ob}	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		10	20	pF
(Common base, input open circuited)						

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. *1: Pulse measurement

*2: Rank classification					
Rank	R	S			
h _{FE1}	120 to 240	170 to 340			

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